Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,204	WANG ET AL.
Examiner	Art Unit
A. Sefer	2826

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
EAST (USPAT, US-PG-Pub, Derwent, EPO & JPO)	11/7/2005	AS			
257/53,101-103,431-432 (text search)	11/7/2005	AS			